

Notice of References Cited	Application/Control No. 10/056,117		Applicant(s)/Patent Under Reexamination WILEY ET AL.	
	Examiner Christopher A. Revak		Art Unit 2131	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,907,529	06-2005	Hirose, Takashi	726/5
*	B	US-6,801,935	10-2004	Shen, Ming-Teh	709/219
*	C	US-5,210,571	05-1993	Peloquin et al.	399/11
*	D	US-2001/0008557	07-2001	Stefik et al.	380/202
*	E	US-6,233,684	05-2001	Stefik et al.	713/176
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	0 862 318 A2	09-1998	EP	Stefik et al	H04N 1/32
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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